

L Number	Hits	Search Text	DB	Time stamp
3	3957	real adj time and develop\$4 near2 (data or progress\$3 or status)	USPAT; US-PGPUB; DERWENT	2003/07/17 10:12
4	32064	((endpoint or end adj point) same (detect\$3 or sens\$3 or monitor\$3 or measur\$3 or determin\$5 or judg\$4))	USPAT; US-PGPUB; DERWENT	2003/07/17 11:19
5	2193	(scatterometry or reflectometry)	USPAT; US-PGPUB; DERWENT	2003/07/17 10:14
6	61343	grating	USPAT; US-PGPUB; DERWENT	2003/07/17 10:15
7	421	((scatterometry or reflectometry) ) and grating	USPAT; US-PGPUB; DERWENT	2003/07/17 10:15
8	53	((endpoint or end adj point) same (detect\$3 or sens\$3 or monitor\$3 or measur\$3 or determin\$5 or judg\$4)) and ((scatterometry or reflectometry) ) and grating)	USPAT; US-PGPUB; DERWENT	2003/07/17 10:15
9	77	feed near3 forward and (real adj time and develop\$4 near2 (data or progress\$3 or status))	USPAT; US-PGPUB; DERWENT	2003/07/17 11:06
10	0	((endpoint or end adj point) same (detect\$3 or sens\$3 or monitor\$3 or measur\$3 or determin\$5 or judg\$4)) and ((scatterometry or reflectometry) ) and grating)) and (feed near3 forward and (real adj time and develop\$4 near2 (data or progress\$3 or status)))	USPAT; US-PGPUB; DERWENT	2003/07/17 10:16
11	0	((endpoint or end adj point) same (detect\$3 or sens\$3 or monitor\$3 or measur\$3 or determin\$5 or judg\$4)) and ((scatterometry or reflectometry) ) and grating)) and fed near3 forward and (real adj time and develop\$4 near2 (data or progress\$3 or status))	USPAT; US-PGPUB; DERWENT	2003/07/17 10:17
12	1	((endpoint or end adj point) same (detect\$3 or sens\$3 or monitor\$3 or measur\$3 or determin\$5 or judg\$4)) and ((scatterometry or reflectometry) ) and grating)) and (real adj time and develop\$4 near2 (data or progress\$3 or status))	USPAT; US-PGPUB; DERWENT	2003/07/17 10:17
13	791	((scatterometry or reflectometry) ) and (wafer or semiconductor same substrate or substrate)	USPAT; US-PGPUB; DERWENT	2003/07/17 10:18
14	288	grating and ((scatterometry or reflectometry) ) and (wafer or semiconductor same substrate or substrate))	USPAT; US-PGPUB; DERWENT	2003/07/17 10:18
15	47	((endpoint or end adj point) same (detect\$3 or sens\$3 or monitor\$3 or measur\$3 or determin\$5 or judg\$4)) and (grating and ((scatterometry or reflectometry) ) and (wafer or semiconductor same substrate or substrate)))	USPAT; US-PGPUB; DERWENT	2003/07/17 10:18
16	12649	(signal or data or information or detect\$3 or sens\$3 or measur\$3) same ((fed or feed) near3 forward or feedforward or feed near3 ahead)	USPAT; US-PGPUB; DERWENT	2003/07/17 11:08
17	272	((endpoint or end adj point) same (detect\$3 or sens\$3 or monitor\$3 or measur\$3 or determin\$5 or judg\$4)) and ((signal or data or information or detect\$3 or sens\$3 or measur\$3) same ((fed or feed) near3 forward or feedforward or feed near3 ahead))	USPAT; US-PGPUB; DERWENT	2003/07/17 11:09

18	23	((scatterometry or reflectometry) ) and (((endpoint or end adj point) same (detect\$3 or sens\$3 or monitor\$3 or measur\$3 or determin\$5 or judg\$4)) and ((signal or data or information or detect\$3 or sens\$3 or measur\$3) same ((fed or feed) near3 forward or feedforward or feed near3 ahead)))	USPAT; US-PGPUB; DERWENT	2003/07/17 11:10
20	1759	(endpoint or end adj point) same (detect\$3 or sens\$3 or monitor\$3 or measur\$3 or determin\$5 or judg\$4) same develop\$4	USPAT; US-PGPUB; DERWENT	2003/07/17 11:20
21	16	((signal or data or information or detect\$3 or sens\$3 or measur\$3) same ((fed or feed) near3 forward or feedforward or feed near3 ahead)) and ((endpoint or end adj point) same (detect\$3 or sens\$3 or monitor\$3 or measur\$3 or determin\$5 or judg\$4) same develop\$4)	USPAT; US-PGPUB; DERWENT	2003/07/17 11:20